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NXP USA Inc. - S9S08DV32F1MLH Datasheet



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Details

| Product Status | Obsolete |
|----------------------------|--|
| Core Processor | S08 |
| Core Size | 8-Bit |
| Speed | 40MHz |
| Connectivity | CANbus, I ² C, LINbus, SCI, SPI |
| Peripherals | LVD, POR, PWM, WDT |
| Number of I/O | 53 |
| Program Memory Size | 32KB (32K x 8) |
| Program Memory Type | FLASH |
| EEPROM Size | - |
| RAM Size | 2K x 8 |
| Voltage - Supply (Vcc/Vdd) | 2.7V ~ 5.5V |
| Data Converters | A/D 16x12b |
| Oscillator Type | External |
| Operating Temperature | -40°C ~ 125°C (TA) |
| Mounting Type | Surface Mount |
| Package / Case | 64-LQFP |
| Supplier Device Package | 64-LQFP (10x10) |
| Purchase URL | https://www.e-xfl.com/product-detail/nxp-semiconductors/s9s08dv32f1mlh |

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Chapter 2 Pins and Connections

This section describes signals that connect to package pins. It includes pinout diagrams, recommended system connections, and detailed discussions of signals.

2.1 Device Pin Assignment

This section shows the pin assignments for MC9S08DV60 Series MCUs in the available packages.



Figure 2-1. 64-Pin LQFP

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Chapter 4 Memory



Figure 4-3. Burst Program Flowchart



An output pin can be selected to have high output drive strength by setting the corresponding bit in the drive strength select register (PTxDSn). When high drive is selected, a pin is capable of sourcing and sinking greater current. Even though every I/O pin can be selected as high drive, the user must ensure that the total current source and sink limits for the MCU are not exceeded. Drive strength selection is intended to affect the DC behavior of I/O pins. However, the AC behavior is also affected. High drive allows a pin to drive a greater load with the same switching speed as a low drive enabled pin into a smaller load. Because of this, the EMC emissions may be affected by enabling pins as high drive.

6.3 Pin Interrupts

Port A, port B, and port D pins can be configured as external interrupt inputs and as an external means of waking the MCU from stop or wait low-power modes.



The block diagram for each port interrupt logic is shown Figure 6-2.

Figure 6-2. Port Interrupt Block Diagram

Writing to the PTxPSn bits in the port interrupt pin select register (PTxPS) independently enables or disables each port pin. Each port can be configured as edge sensitive or edge and level sensitive based on the PTxMOD bit in the port interrupt status and control register (PTxSC). Edge sensitivity can be software programmed to be either falling or rising; the level can be either low or high. The polarity of the edge or edge and level sensitivity is selected using the PTxESn bits in the port interrupt edge select register (PTxSC).

Synchronous logic is used to detect edges. Prior to detecting an edge, enabled port inputs must be at the deasserted logic level. A falling edge is detected when an enabled port input signal is seen as a logic 1 (the deasserted level) during one bus cycle and then a logic 0 (the asserted level) during the next cycle. A rising edge is detected when the input signal is seen as a logic 0 during one bus cycle and then a logic 1 during the next cycle.

6.3.1 Edge Only Sensitivity

A valid edge on an enabled port pin will set PTxIF in PTxSC. If PTxIE in PTxSC is set, an interrupt request will be presented to the CPU. Clearing of PTxIF is accomplished by writing a 1 to PTxACK in PTxSC.



Chapter 6 Parallel Input/Output Control

6.5.3 Port C Registers

Port C is controlled by the registers listed below.

6.5.3.1 Port C Data Register (PTCD)



Figure 6-19. Port C Data Register (PTCD)

Table 6-17. PTCD Register Field Descriptions

| Field | Description |
|------------------|--|
| 7:0 PTCD[7:0] | Port C Data Register Bits — For port C pins that are inputs, reads return the logic level on the pin. For port C pins that are configured as outputs, reads return the last value written to this register. Writes are latched into all bits of this register. For port C pins that are configured as outputs, the logic level is driven out the corresponding MCU pin. Reset forces PTCD to all 0s, but these 0s are not driven out the corresponding pins because reset also configures all port pins as high-impedance inputs with pull-ups disabled. |

6.5.3.2 Port C Data Direction Register (PTCDD)

| | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|--------|--------|--------|--------|--------|--------|--------|--------|--------|
| R W | PTCDD7 | PTCDD6 | PTCDD5 | PTCDD4 | PTCDD3 | PTCDD2 | PTCDD1 | PTCDD0 |
| Reset: | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

Figure 6-20. Port C Data Direction Register (PTCDD)

Table 6-18. PTCDD Register Field Descriptions

| Field | Description |
|-------------------|---|
| 7:0 PTCDD[7:0] | Data Direction for Port C Bits — These read/write bits control the direction of port C pins and what is read for PTCD reads. |
| | Input (output driver disabled) and reads return the pin value. Output driver enabled for port C bit n and PTCD reads return the contents of PTCDn. |



6.5.7 Port G Registers

Port G is controlled by the registers listed below.

6.5.7.1 Port G Data Register (PTGD)



Figure 6-42. Port G Data Register (PTGD)

Table 6-40. PTGD Register Field Descriptions

| Field | Description |
|------------------|---|
| 5:0 PTGD[5:0] | Port G Data Register Bits — For port G pins that are inputs, reads return the logic level on the pin. For port G pins that are configured as outputs, reads return the last value written to this register. Writes are latched into all bits of this register. For port G pins that are configured as outputs, the logic level is driven out the corresponding MCU pin. Reset forces PTGD to all 0s, but these 0s are not driven out the corresponding pins because reset also configures all port pins as high-impedance inputs with pull-ups disabled. |

6.5.7.2 Port G Data Direction Register (PTGDD)



Figure 6-43. Port G Data Direction Register (PTGDD)

Table 6-41. PTGDD Register Field Descriptions

| Field | Description |
|-------------------|---|
| 5:0 PTGDD[5:0] | Data Direction for Port G Bits — These read/write bits control the direction of port G pins and what is read for PTGD reads. 0 Input (output driver disabled) and reads return the pin value. 1 Output driver enabled for port G bit n and PTGD reads return the contents of PTGDn. |



Chapter 7 Central Processor Unit (S08CPUV3)

| Source | Operation | ldress 1ode | Object Code | /cles | Cyc-by-Cyc Details | Affect on CCR | |
|--|--|--|--|--|--|-----------------------|---------|
| | | PA | | ΰ | Dotano | V 1 1 H | INZC |
| BPL rel | Branch if Plus (if N = 0) | REL | 2A rr | 3 | qqq | - 1 1 - | |
| BRA rel | Branch Always (if I = 1) | REL | 20 rr | 3 | ppp | - 1 1 - | |
| BRCLR n,opr8a,rel | Branch if Bit <i>n</i> in Memory Clear (if (Mn) = 0) | DIR (b0) DIR (b1) DIR (b2) DIR (b3) DIR (b3) DIR (b4) DIR (b5) DIR (b6) DIR (b7) | 01 dd rr 03 dd rr 05 dd rr 07 dd rr 09 dd rr 0B dd rr 0D dd rr 0F dd rr | 5 5 5 5 5 5 5 5 5 | rpppp rpppp rpppp rpppp rpppp rpppp | - 1 1 - | \$ |
| BRN rel | Branch Never (if I = 0) | REL | 21 rr | 3 | qqq | - 1 1 - | |
| BRSET n,opr8a,rel | Branch if Bit <i>n</i> in Memory Set (if (Mn) = 1) | DIR (b0) DIR (b1) DIR (b2) DIR (b3) DIR (b3) DIR (b4) DIR (b5) DIR (b6) DIR (b7) | 00 dd rr 02 dd rr 04 dd rr 06 dd rr 08 dd rr 0A dd rr 0C dd rr 0E dd rr | 5 5 5 5 5 5 5 5 5 | rpppp rpppp rpppp rpppp rpppp rpppp | -11- | \$ |
| BSET n,opr8a | Set Bit <i>n</i> in Memory (Mn ← 1) | DIR (b0) DIR (b1) DIR (b2) DIR (b3) DIR (b3) DIR (b4) DIR (b5) DIR (b6) DIR (b7) | 10 dd 12 dd 14 dd 16 dd 18 dd 1A dd 1C dd 1E dd | 5 5 5 5 5 5 5 5 5 5 5 5 | rfwpp rfwpp rfwpp rfwpp rfwpp rfwpp rfwpp rfwpp | - 1 1 - | |
| BSR rel | $\begin{array}{c} \text{Branch to Subroutine} \\ \text{PC} \leftarrow (\text{PC}) + \$0002 \\ \text{push (PCL); SP} \leftarrow (\text{SP}) - \$0001 \\ \text{push (PCH); SP} \leftarrow (\text{SP}) - \$0001 \\ \text{PC} \leftarrow (\text{PC}) + \textit{rel} \end{array}$ | REL | AD rr | 5 | qqqaa | - 1 1 - | |
| CBEQ opr8a,rel CBEQA #opr8i,rel CBEQX #opr8i,rel CBEQ oprx8,X+,rel CBEQ ,X+,rel CBEQ oprx8,SP,rel | Compare and Branch if $(A) = (M)$ Branch if $(A) = (M)$ Branch if $(X) = (M)$ Branch if $(A) = (M)$ Branch if $(A) = (M)$ Branch if $(A) = (M)$ | DIR IMM IX1+ IX+ SP1 | 31 dd rr 41 ii rr 51 ii rr 61 ff rr 71 rr 9E 61 ff rr | 5 4 5 5 6 | rpppp pppp pppp rpppp rfppp prpppp | - 1 1 - | |
| CLC | Clear Carry Bit (C \leftarrow 0) | INH | 98 | 1 | q | - 1 1 - | 0 |
| CLI | Clear Interrupt Mask Bit (I \leftarrow 0) | INH | 9A | 1 | q | - 1 1 - | 0 |
| CLR opr8a CLRA CLRX CLRH CLR oprx8,X CLR ,X CLR oprx8,SP | Clear $M \leftarrow \$00$ $A \leftarrow \$00$ $X \leftarrow \$00$ $H \leftarrow \$00$ $M \leftarrow \$00$ $M \leftarrow \$00$ $M \leftarrow \$00$ | DIR INH INH IX1 IX SP1 | 3F dd 4F 5F 8C 6F ff 7F 9E 6F ff | 5 1 1 5 4 6 | rfwpp p p rfwpp rfwp prfwpp | 011- | - 0 1 - |

Table 7-2. Instruction Set Summary (Sheet 3 of 9)



9.3 Memory Map/Register Definition

The ACMP includes one register:

• An 8-bit status and control register

Refer to the direct-page register summary in the memory section of this document for the absolute address assignments for the ACMP register. This section refers to register and control bits only by their names and relative address offsets.

Some MCUs may have more than one ACMP, so register names include placeholder characters (x) to identify which ACMP is being referenced.

| Table | 9-2. | ACMP | Register | Summary |
|-------|------|------|----------|---------|
|-------|------|------|----------|---------|

| Name | | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|---------|--------|------|-------|-----|------|-----|-------|-----|-----|
| ACMPxSC | R W | ACME | ACBGS | ACF | ACIE | ACO | ACOPE | ACM | NOD |

9.3.1 ACMPx Status and Control Register (ACMPxSC)

ACMPxSC contains the status flag and control bits used to enable and configure the ACMP.



Figure 9-3. ACMPx Status and Control Register (ACMPxSC)

Table 9-3. ACMPxSC Field Descriptions

| Field | Description |
|------------|--|
| 7 ACME | Analog Comparator Module Enable. Enables the ACMP module. 0 ACMP not enabled 1 ACMP is enabled |
| 6 ACBGS | Analog Comparator Bandgap Select. Selects between the bandgap reference voltage or the ACMPx+ pin as the input to the non-inverting input of the analog comparator. 0 External pin ACMPx+ selected as non-inverting input to comparator 1 Internal reference select as non-inverting input to comparator |
| 5 ACF | Analog Comparator Flag. ACF is set when a compare event occurs. Compare events are defined by ACMOD. ACF is cleared by writing a one to it. 0 Compare event has not occurred 1 Compare event has occurred |
| 4 ACIE | Analog Comparator Interrupt Enable. Enables the interrupt from the ACMP. When ACIE is set, an interrupt is asserted when ACF is set. 0 Interrupt disabled 1 Interrupt enabled |



10.3.2 Status and Control Register 2 (ADCSC2)

The ADCSC2 register controls the compare function, conversion trigger, and conversion active of the ADC module.



Figure 10-4. Status and Control Register 2 (ADCSC2)

Table 10-5. ADCSC2 Register Field Descriptions

| Field | Description |
|------------|---|
| 7 ADACT | Conversion Active. Indicates that a conversion is in progress. ADACT is set when a conversion is initiated and cleared when a conversion is completed or aborted. Conversion not in progress Conversion in progress |
| 6 ADTRG | Conversion Trigger Select. Selects the type of trigger used for initiating a conversion. Two types of triggers are selectable: software trigger and hardware trigger. When software trigger is selected, a conversion is initiated following a write to ADCSC1. When hardware trigger is selected, a conversion is initiated following the assertion of the ADHWT input. 0 Software trigger selected 1 Hardware trigger selected |
| 5 ACFE | Compare Function Enable. Enables the compare function. 0 Compare function disabled 1 Compare function enabled |
| 4 ACFGT | Compare Function Greater Than Enable. Configures the compare function to trigger when the result of the conversion of the input being monitored is greater than or equal to the compare value. The compare function defaults to triggering when the result of the compare of the input being monitored is less than the compare value. 0 Compare triggers when input is less than compare value 1 Compare triggers when input is greater than or equal to compare value |

10.3.3 Data Result High Register (ADCRH)

In 12-bit operation, ADCRH contains the upper four bits of the result of a 12-bit conversion. In 10-bit mode, ADCRH contains the upper two bits of the result of a 10-bit conversion. When configured for 10-bit mode, ADR[11:10] are cleared. When configured for 8-bit mode, ADR[11:8] are cleared.

In 12-bit and 10-bit mode, ADCRH is updated each time a conversion completes except when automatic compare is enabled and the compare condition is not met. When a compare event does occur, the value is the addition of the conversion result and the two's complement of the compare value. In 12-bit and 10-bit mode, reading ADCRH prevents the ADC from transferring subsequent conversion results into the result registers until ADCRL is read. If ADCRL is not read until after the next conversion is completed, the intermediate conversion result is lost. In 8-bit mode, there is no interlocking with ADCRL.



Chapter 11 Inter-Integrated Circuit (S08IICV2)

Chapter 12 Freescale Controller Area Network (S08MSCANV1)





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NOTE

The CANTIER register is held in the reset state when the initialization mode is active (INITRQ = 1 and INITAK = 1). This register is writable when not in initialization mode (INITRQ = 0 and INITAK = 0).

Read: Anytime

Write: Anytime when not in initialization mode

Table 12-12. CANTIER Register Field Descriptions

| Field | Description |
|------------|---|
| 2:0 | Transmitter Empty Interrupt Enable |
| TXEIE[2:0] | 0 No interrupt request is generated from this event. |
| | 1 A transmitter empty (transmit buffer available for transmission) event causes a transmitter empty interrupt |
| | request. See Section 12.5.2.2, "Transmit Structures" for details. |

12.3.8 MSCAN Transmitter Message Abort Request Register (CANTARQ)

The CANTARQ register allows abort request of messages queued for transmission.



Figure 12-12. MSCAN Transmitter Message Abort Request Register (CANTARQ)

NOTE

The CANTARQ register is held in the reset state when the initialization mode is active (INITRQ = 1 and INITAK = 1). This register is writable when not in initialization mode (INITRQ = 0 and INITAK = 0).

Read: Anytime

Write: Anytime when not in initialization mode

| Field | Description |
|-------------------|--|
| 2:0 ABTRQ[2:0] | Abort Request — The CPU sets the ABTRQx bit to request that a scheduled message buffer (TXEx = 0) be aborted. The MSCAN grants the request if the message has not already started transmission, or if the transmission is not successful (lost arbitration or error). When a message is aborted, the associated TXE (see Section 12.3.6, "MSCAN Transmitter Flag Register (CANTFLG)") and abort acknowledge flags (ABTAK, see Section 12.3.9, "MSCAN Transmitter Message Abort Acknowledge Register (CANTAAK)") are set and a transmit interrupt occurs if enabled. The CPU cannot reset ABTRQx. ABTRQx is reset whenever the associated TXE flag is set. 0 No abort request 1 Abort request pending |



Chapter 12 Freescale's Controller Area Network (S08MSCANV1)



Figure 12-28. Identifier Register 3 (IDR3) — Extended Identifier Mapping

Table 12-28. IDR3 Register Field Descriptions — Extended

| Field | Description |
|----------------|---|
| 7:1 ID[6:0] | Extended Format Identifier — The identifiers consist of 29 bits (ID[28:0]) for the extended format. ID28 is the most significant bit and is transmitted first on the CAN bus during the arbithation procedure. The priority of an identifier is defined to be highest for the smallest binary number. |
| 0 RTR | Remote Transmission Request — This flag reflects the status of the remote transmission request bit in the CAN frame. In the case of a receive buffer, it indicates the status of the received frame and supports the transmission of an answering frame in software. In the case of a transmit buffer, this flag defines the setting of the RTR bit to be sent. 0 Data frame 1 Remote frame |

12.4.2 IDR0–IDR3 for Standard Identifier Mapping



Figure 12-29. Identifier Register 0 — Standard Mapping

| | Table 12-29. IDR0 Register Field Descriptions — Standard |
|---|--|
| 1 | Description |

| Field | Description |
|----------|---|
| 7:0 | Standard Format Identifier — The identifiers consist of 11 bits (ID[10:0]) for the standard format. ID10 is the |
| ID[10:3] | most significant bit and is transmitted first on the CAN bus during the arbitration procedure. The priority of an |
| | identifier is defined to be highest for the smallest binary number. See also ID bits in Table 12-30. |
| | |

| | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|--------|-----|-----|-----|-----|--------------------|---|---|---|
| R W | ID2 | ID1 | ID0 | RTR | IDE ⁽¹⁾ | | | |
| Reset: | x | x | x | x | x | x | x | x |

= Unused; always read 'x'

Figure 12-30. Identifier Register 1 — Standard Mapping

¹ IDE is 0.

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Chapter 12 Freescale's Controller Area Network (S08MSCANV1)

Chapter 13 Serial Peripheral Interface (S08SPIV3)

in LSBFE. Both variations of SPSCK polarity are shown, but only one of these waveforms applies for a specific transfer, depending on the value in CPOL. The SAMPLE IN waveform applies to the MOSI input of a slave or the MISO input of a master. The MOSI waveform applies to the MOSI output pin from a master and the MISO waveform applies to the MISO output from a slave. The \overline{SS} OUT waveform applies to the slave select output from a master (provided MODFEN and SSOE = 1). The master \overline{SS} output goes to active low at the start of the first bit time of the transfer and goes back high one-half SPSCK cycle after the end of the eighth bit time of the transfer. The \overline{SS} IN waveform applies to the slave select input of a slave.





When CPHA = 0, the slave begins to drive its MISO output with the first data bit value (MSB or LSB depending on LSBFE) when \overline{SS} goes to active low. The first SPSCK edge causes both the master and the slave to sample the data bit values on their MISO and MOSI inputs, respectively. At the second SPSCK edge, the SPI shifter shifts one bit position which shifts in the bit value that was just sampled and shifts the second data bit value out the other end of the shifter to the MOSI and MISO outputs of the master and slave, respectively. When CPHA = 0, the slave's \overline{SS} input must go to its inactive high level between transfers.



| Table 14-5. SCIxC2 Field Descri | ptions (continued) |
|---------------------------------|--------------------|
|---------------------------------|--------------------|

| Field | Description |
|----------|--|
| 3 TE | Transmitter Enable0Transmitter off.1Transmitter on.TE must be 1 in order to use the SCI transmitter. When TE = 1, the SCI forces the TxD pin to act as an output for the SCI system.When the SCI is configured for single-wire operation (LOOPS = RSRC = 1), TXDIR controls the direction of traffic on the single SCI communication line (TxD pin).TE also can be used to queue an idle character by writing TE = 0 then TE = 1 while a transmission is in progress.Refer to Section 14.3.2.1, "Send Break and Queued Idle" for more details.When TE is written to 0, the transmitter keeps control of the port TxD pin until any data, queued idle, or queued break character finishes transmitting before allowing the pin to revert to a general-purpose I/O pin. |
| 2 RE | Receiver Enable — When the SCI receiver is off, the RxD pin reverts to being a general-purpose port I/O pin. If LOOPS = 1 the RxD pin reverts to being a general-purpose I/O pin even if RE = 1. 0 Receiver off. 1 Receiver on. |
| 1 RWU | Receiver Wakeup Control — This bit can be written to 1 to place the SCI receiver in a standby state where it waits for automatic hardware detection of a selected wakeup condition. The wakeup condition is either an idle line between messages (WAKE = 0, idle-line wakeup), or a logic 1 in the most significant data bit in a character (WAKE = 1, address-mark wakeup). Application software sets RWU and (normally) a selected hardware condition automatically clears RWU. Refer to Section 14.3.3.2, "Receiver Wakeup Operation" for more details. 0 Normal SCI receiver operation. 1 SCI receiver in standby waiting for wakeup condition. |
| 0 SBK | Send Break — Writing a 1 and then a 0 to SBK queues a break character in the transmit data stream. Additional break characters of 10 or 11 (13 or 14 if BRK13 = 1) bit times of logic 0 are queued as long as SBK = 1. Depending on the timing of the set and clear of SBK relative to the information currently being transmitted, a second break character may be queued before software clears SBK. Refer to Section 14.3.2.1, "Send Break and Queued Idle" for more details. 0 Normal transmitter operation. 1 Queue break character(s) to be sent. |

14.2.4 SCI Status Register 1 (SCIxS1)

This register has eight read-only status flags. Writes have no effect. Special software sequences (which do not involve writing to this register) are used to clear these status flags.



Figure 14-8. SCI Status Register 1 (SCIxS1)

| Chapter 15 Real-Time | Counter (S08RTC) | /1) | | | | |
|--------------------------------|------------------|------|------|------|------|------|
| Internal 1-kHz Clock Source | | | | | | |
| RTC Clock (RTCPS = 0xA) | | | | | | |
| RTCCNT | 0x52 | 0x53 | 0x54 | 0x55 | 0x00 | 0x01 |
| | | | | | | |
| RTIF | | | | | | |
| 570105 | [| | | | | 1 |
| RICMOD | | | 0x | 55 | | |

Figure 15-6. RTC Counter Overflow Example

In the example of Figure 15-6, the selected clock source is the 1-kHz internal oscillator clock source. The prescaler (RTCPS) is set to 0xA or divide-by-4. The modulo value in the RTCMOD register is set to 0x55. When the counter, RTCCNT, reaches the modulo value of 0x55, the counter overflows to 0x00 and continues counting. The real-time interrupt flag, RTIF, sets when the counter value changes from 0x55 to 0x00. A real-time interrupt is generated when RTIF is set, if RTIE is set.

15.5 Initialization/Application Information

This section provides example code to give some basic direction to a user on how to initialize and configure the RTC module. The example software is implemented in C language.

The example below shows how to implement time of day with the RTC using the 1-kHz clock source to achieve the lowest possible power consumption. Because the 1-kHz clock source is not as accurate as a crystal, software can be added for any adjustments. For accuracy without adjustments at the expense of additional power consumption, the external clock (ERCLK) or the internal clock (IRCLK) can be selected with appropriate prescaler and modulo values.



Chapter 16 Timer/PWM Module (S08TPMV3)

The TPM channels are programmable independently as input capture, output compare, or edge-aligned PWM channels. Alternately, the TPM can be configured to produce CPWM outputs on all channels. When the TPM is configured for CPWMs, the counter operates as an up/down counter; input capture, output compare, and EPWM functions are not practical.

If a channel is configured as input capture, an internal pullup device may be enabled for that channel. The details of how a module interacts with pin controls depends upon the chip implementation because the I/O pins and associated general purpose I/O controls are not part of the module. Refer to the discussion of the I/O port logic in a full-chip specification.

Because center-aligned PWMs are usually used to drive 3-phase AC-induction motors and brushless DC motors, they are typically used in sets of three or six channels.

16.2 Signal Description

Table 16-1 shows the user-accessible signals for the TPM. The number of channels may be varied from one to eight. When an external clock is included, it can be shared with the same pin as any TPM channel; however, it could be connected to a separate input pin. Refer to the I/O pin descriptions in full-chip specification for the specific chip implementation.

| Name | Function |
|----------------------|---|
| EXTCLK ¹ | External clock source which may be selected to drive the TPM counter. |
| TPMxCHn ² | I/O pin associated with TPM channel n |

| Table | 16-1. | Signal | Pro | perties |
|--------------|-------|---------|-----|---------|
| abic | 10-1. | orginar | 110 | perties |

¹ When preset, this signal can share any channel pin; however depending upon full-chip implementation, this signal could be connected to a separate external pin.

² n=channel number (1 to 8)

Refer to documentation for the full-chip for details about reset states, port connections, and whether there is any pullup device on these pins.

TPM channel pins can be associated with general purpose I/O pins and have passive pullup devices which can be enabled with a control bit when the TPM or general purpose I/O controls have configured the associated pin as an input. When no TPM function is enabled to use a corresponding pin, the pin reverts to being controlled by general purpose I/O controls, including the port-data and data-direction registers. Immediately after reset, no TPM functions are enabled, so all associated pins revert to general purpose I/O control.

16.2.1 Detailed Signal Descriptions

This section describes each user-accessible pin signal in detail. Although Table 16-1 grouped all channel pins together, any TPM pin can be shared with the external clock source signal. Since I/O pin logic is not part of the TPM, refer to full-chip documentation for a specific derivative for more details about the interaction of TPM pin functions and general purpose I/O controls including port data, data direction, and pullup controls.



Chapter 17 Development Support

the host must perform ((8 - CNT) - 1) dummy reads of the FIFO to advance it to the first significant entry in the FIFO.

In most trigger modes, the information stored in the FIFO consists of 16-bit change-of-flow addresses. In these cases, read DBGFH then DBGFL to get one coherent word of information out of the FIFO. Reading DBGFL (the low-order byte of the FIFO data port) causes the FIFO to shift so the next word of information is available at the FIFO data port. In the event-only trigger modes (see Section 17.3.5, "Trigger Modes"), 8-bit data information is stored into the FIFO. In these cases, the high-order half of the FIFO (DBGFH) is not used and data is read out of the FIFO by simply reading DBGFL. Each time DBGFL is read, the FIFO is shifted so the next data value is available through the FIFO data port at DBGFL.

In trigger modes where the FIFO is storing change-of-flow addresses, there is a delay between CPU addresses and the input side of the FIFO. Because of this delay, if the trigger event itself is a change-of-flow address or a change-of-flow address appears during the next two bus cycles after a trigger event starts the FIFO, it will not be saved into the FIFO. In the case of an end-trace, if the trigger event is a change-of-flow, it will be saved as the last change-of-flow entry for that debug run.

The FIFO can also be used to generate a profile of executed instruction addresses when the debugger is not armed. When ARM = 0, reading DBGFL causes the address of the most-recently fetched opcode to be saved in the FIFO. To use the profiling feature, a host debugger would read addresses out of the FIFO by reading DBGFH then DBGFL at regular periodic intervals. The first eight values would be discarded because they correspond to the eight DBGFL reads needed to initially fill the FIFO. Additional periodic reads of DBGFH and DBGFL return delayed information about executed instructions so the host debugger can develop a profile of executed instruction addresses.

17.3.3 Change-of-Flow Information

To minimize the amount of information stored in the FIFO, only information related to instructions that cause a change to the normal sequential execution of instructions is stored. With knowledge of the source and object code program stored in the target system, an external debugger system can reconstruct the path of execution through many instructions from the change-of-flow information stored in the FIFO.

For conditional branch instructions where the branch is taken (branch condition was true), the source address is stored (the address of the conditional branch opcode). Because BRA and BRN instructions are not conditional, these events do not cause change-of-flow information to be stored in the FIFO.

Indirect JMP and JSR instructions use the current contents of the H:X index register pair to determine the destination address, so the debug system stores the run-time destination address for any indirect JMP or JSR. For interrupts, RTI, or RTS, the destination address is stored in the FIFO as change-of-flow information.

17.3.4 Tag vs. Force Breakpoints and Triggers

Tagging is a term that refers to identifying an instruction opcode as it is fetched into the instruction queue, but not taking any other action until and unless that instruction is actually executed by the CPU. This distinction is important because any change-of-flow from a jump, branch, subroutine call, or interrupt causes some instructions that have been fetched into the instruction queue to be thrown away without being executed.



Appendix A Electrical Characteristics

A.1 Introduction

This section contains the most accurate electrical and timing information for the MC9S08DV60 Series of microcontrollers available at the time of publication.

A.2 Parameter Classification

The electrical parameters shown in this supplement are guaranteed by various methods. To give the customer a better understanding the following classification is used and the parameters are tagged accordingly in the tables where appropriate:

| Р | Those parameters are guaranteed during production testing on each individual device. |
|---|--|
| С | Those parameters are achieved by the design characterization by measuring a statistically relevant sample size across process variations. |
| т | Those parameters are achieved by design characterization on a small sample size from typical devices under typical conditions unless otherwise noted. All values shown in the typical column are within this category. |
| D | Those parameters are derived mainly from simulations. |

Table A-1. Parameter Classifications

NOTE

The classification is shown in the column labeled "C" in the parameter tables where appropriate.

A.3 Absolute Maximum Ratings

Absolute maximum ratings are stress ratings only, and functional operation at the maxima is not guaranteed. Stress beyond the limits specified in Table A-2 may affect device reliability or cause permanent damage to the device. For functional operating conditions, refer to the remaining tables in this section.



| | | | i | | | | | |
|---|--------------------------|--------|---------------------|-----|------------------|---------|------------------|--|
| Characteristic | Conditions | С | Symb | Min | Typ ¹ | Max | Unit | Comment |
| Conversion Time (Including sample time) | Short Sample (ADLSMP=0) | D | t _{ADC} | _ | 20 | _ | ADCK cycles | See Table 10-13 for conversion time variances |
| | Long Sample (ADLSMP=1) | | | _ | 40 | _ | | |
| Sample Time | Short Sample (ADLSMP=0) | D | t _{ADS} | | 3.5 | | ADCK cycles | |
| | Long Sample (ADLSMP=1) | | | _ | 23.5 | | | |
| Total Unadjusted Error | 12 bit mode | т | E _{TUE} | _ | ±3.0 | ±10 | LSB ² | Includes quantization |
| | 10 bit mode | Р | - | | ±1 | ±2.5 | | |
| | 8 bit mode | т | | | ±0.5 | ±1.0 | | |
| Differential Non-Linearity | 12 bit mode | т | DNL | _ | ±1.75 | ±4.0 | LSB ² | |
| | 10 bit mode ³ | Р | - | | ±0.5 | ±1.0 | | |
| | 8 bit mode ³ | Т | | | ±0.3 | ±0.5 | | |
| Integral Non-Linearity | 12 bit mode | Т | INL | | ±1.5 | ±4.0 | LSB ² | |
| | 10 bit mode | Т | | | ±0.5 | ±1.0 | | |
| | 8 bit mode | Т | 1 | _ | ±0.3 | ±0.5 | | |
| Zero-Scale Error | 12 bit mode | T P | E _{ZS} | | ±1.5 | ±6.0 | LSB ² | $V_{ADIN} = V_{SSAD}$ |
| | 10 bit mode | | | | ±0.5 | ±1.5 | | |
| | 8 bit mode | Т | | _ | ±0.5 | ±0.5 | | |
| Full-Scale Error | 12 bit mode | Т | E _{FS} | | ±1 | ±4.0 | LSB ² | $V_{ADIN} = V_{DDAD}$ |
| | 10 bit mode | Т | | | ±0.5 | ±1 | | |
| | 8 bit mode | Т | | _ | ±0.5 | ±0.5 | | |
| Quantization Error | 12 bit mode | D | EQ | | -1 to 0 | -1 to 0 | LSB ² | |
| | 10 bit mode | | | | | ±0.5 | | |
| | 8 bit mode | | | _ | _ | ±0.5 | | |
| Input Leakage Error | 12 bit mode | D | E _{IL} | | ±1 | ±10.0 | LSB ² | Pad leakage ⁴ * R _{AS} |
| | 10 bit mode | | | | ±0.2 | ±2.5 | | |
| | 8 bit mode | | | _ | ±0.1 | ±1 | | |
| Temp Sensor Slope | -40°C– 25°C | D | m | _ | 3.266 | _ | mV/°C | |
| | 25°C– 125°C | | | _ | 3.638 | _ | | |
| Temp Sensor Voltage | 25°C | D | V _{TEMP25} | _ | 1.396 | _ | V | |

Table A-10. 12-bit ADC Characteristics ($V_{REFH} = V_{DDAD}$, $V_{REFL} = V_{SSAD}$) (continued)

¹ Typical values assume V_{DDAD} = 5.0V, Temp = 25°C, f_{ADCK}=1.0MHz unless otherwise stated. Typical values are for reference only and are not tested in production.
 ² 1 LSB = (V_{REFH} - V_{REFL})/2^N